

An IATF 16949, ISO9001 and ISO 14001/ISO 45001 Certified Company





Sensitive Gate SCR

BT151X



TO-220FP

TO-220FP Fully Isolated Plastic Package RoHS compliant

GENERAL DESCRIPTION:

The BT151X SCR is suitable to fit all models of control found in applications such as motor control, Industrial and Domestic lighting, heating and static switching, voltage regulation circuits.

FEATURES:

- 1. High blocking voltage
- 2. Low on-state voltage and high I_{TSM}
- 3. High heat dissipation and durability
- 4. This product is available in AEC-Q101 Compliant and PPAP Capable also.

Note: For AEC-Q101 compliant products, please use suffix -AQ in the part number while ordering.

APPLICATIONS: Its application is in solid state relay, motorcycle, power charger, T-tools etc

ABSOLUTE MAXIMUM RATINGS (Ta = 25 °C Unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITION	VALUE	UNIT	
Repetitive Peak Off-State Voltage	V_{DRM}	DT151V 650/000	650/800	V	
Repetitive Peak Reverse Voltage	V_{RRM}	BT151X - 650/800 650/80		<u> </u>	
Average on-state current	I _{T (AV)}	half sine wave, T _{amb} ≤109°C	7.5	Α	
On-State RMS Current	I _{T (RMS)}	All conduction angles	12	Α	
Non Repetitive Surge Peak On-State Current	I _{TSM}	full Sine wave, T _j =25°C, t=10ms	110	А	
I2t Value for Fusing	l ² t	t=10ms	50	A^2s	
Repetitive Rate of Rise of On-State Current after Triggering	di/dt	I_{TM} =20A, I_{G} =0.2A, dI_{G} / dt =0.2A/ms	50	A/µs	
Storage Temperature	T _{stg}		-40 to +150	°C	
Operation Junction Temperature	T _J		125	°C	
PARAMETER	SYMBOL	TYP	MAX	UNIT	
Thermal Resistance, Junction to Case	R _{thJ-C}		1.3	K/W	
Thermal Resistance, Junction to Ambient	R _{thJ-A}	60		K/W	
Peak Gate Current	I_{GM}		2	Α	
Peak Gate Voltage	V_{GM}		5.0	V	
Peak reverse gate current	V_{RGM}		5.0	V	
Peak gate power	P_{GM}		5.0	W	
Average Gate Power (Over any 20ms period)	P _{G(AV)}		0.5	W	







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ELECTRICAL CHARACTERISTICS at (Ta = 25 °C Unless otherwise specified)

PARAMETER	SYMBOL	CVMPOL TEST COMPITION	VALUE			UNIT
PARAIVIETER	SYMBOL TEST CONDITION		MIN	TYP	MAX	UNII
Peak Repetitive Forward Blocking Current	I _{DRM}	V _{DM} =V _{DRM(MAX)} ; T _j =125°C	1	0.1	0.5	mA
Peak Repetitive Reverse Blocking Current	I _{RRM}	V _{RM} =V _{RRM(MAX)} ; T _j =125°C		0.1	0.5	mA
Peak On-State Voltage	V_{TM}	I _{TM} =23A		1.45	1.8	V
Gate Trigger Current	I _{GT}	$V_{DM} = 12V, I_{T} = 0.1A$	1	4	15	mA
Gate Trigger Voltage	V_{GT}	V _{DM} =12V, I _T =0.1A		0.7	1.5	V
Holding Current	I _H	V_{DM} =12V, I_{GT} =0.1A	-	7	20	mA
Latching Current	ΙL	V_{DM} =12V, I_{GT} =0.1A	1	10	40	mA
Rise of Off-State Voltage	dV/dt	V _{DM} =67% V _{DRM(MAX)} , T _j =125°C Gate Open	50	130		V/µs
Gate controlled turn-on time	tgt	$T_{M=40A}$, $V_{DM}=V_{DRM(MAX)}$, $I_{G}=0.1A$, $dI_{G}/dt=5A/\mu S$		2		μs





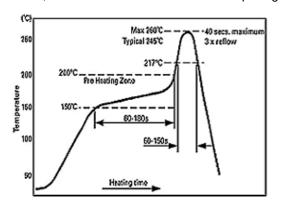


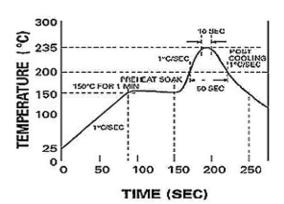
Recommended Reflow Solder Profiles

The recommended reflow solder profiles for Pb and Pb-free devices are shown below.

Figure 1 shows the recommended solder profile for devices that have Pb-free terminal plating, and where a Pb-free solder is used.

Figure 2 shows the recommended solder profile for devices with Pb-free terminal plating used with leaded solder, or for devices with leaded terminal plating used with a leaded solder.





Reflow profiles in tabular form

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Profile Feature	Sn-Pb System	Pb-Free System		
Average Ramp-Up Rate	~3°C/second	~3°C/second		
Preheat - Temperature Range - Time	150-170°C 60-180 seconds	150-200°C 60-180 seconds		
Time maintained above: - Temperature - Time	200°C 30-50 seconds	217°C 60-150 seconds		
Peak Temperature	235°C	260°C max.		
Time within +0 -5°C of actual Peak	10 seconds	40 seconds		
Ramp-Down Rate	3°C/second max.	6°C/second max.		



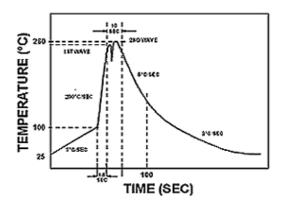




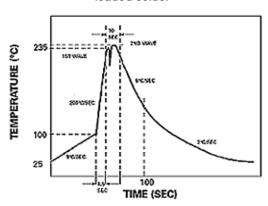


Recommended Wave Solder Profiles

The Recommended solder Profile For Devices with Pb-free terminal plating where a Pb-free solder is used



The Recommended solder Profile For Devices with Pb-free terminal plating used with leaded solder, or for devices with leaded terminal plating used with leaded solder



Wave Profiles in Tabular Form

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Profile Feature	Sn-Pb System	Pb-free System		
Average Ramp-Up Rate	~200°C/second	~200°C/second		
Heating rate during preheat	Typical 1-2, Max 4°C/sec	Typical 1-2, Max 4°C/Sec		
Final preheat Temperature	Within 125°C of Solder Temp	Within 125°C of Solder Temp		
Peak Temperature	235°C	260°C max.		
Time within +0 -5°C of actual Peak	10 seconds	10 seconds		
Ramp-Down Rate	5°C/second max.	5°C/second max.		









TYPICAL CHARACTERISTICS CURVES

Fig 1: Maximum On-state dissipation P_{tot} Versus Average On-state Current, $I_{T(AV)}$

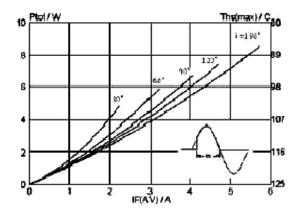


Fig 2: Typical and Maximum On-state Characteristics

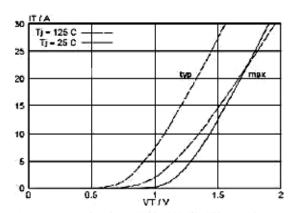
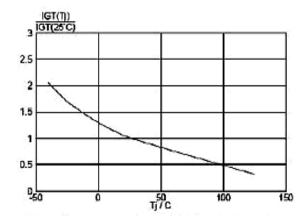


Fig 3 : Normalized gate trigger current $I_{\text{GT}}(T_j)$, $I_{\text{GT}}(25^{\circ}\text{C})$, Versus Junction Temperature T_j

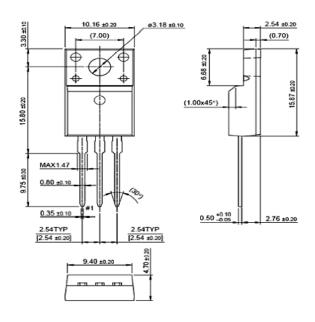






PACKAGE DETAILS

TO-220FP Plastic Package



PIN CONFIGURATION

- 1. CATHODE
- 2. ANODE
- 3. GATE









Recommended Product Storage Environment for Discrete Semiconductor Devices

This storage environment assumes that the Diodes and transistors are packed properly inside the original packing supplied by CDIL.

- · Temperature 5 °C to 30 °C
- · Humidity between 40 to 70 %RH
- · Air should be clean.
- · Avoid harmful gas or dust.
- · Avoid outdoor exposure or storage in areas subject to rain or water spraying .
- · Avoid storage in areas subject to corrosive gas or dust. Product shall not be stored in areas exposed to direct sunlight.
- · Avoid rapid change of temperature.
- · Avoid condensation.
- · Mechanical stress such as vibration and impact shall be avoided.
- · The product shall not be placed directly on the floor.
- The product shall be stored on a plane area. They should not be turned upside down. They should not be placed against the wall.

Shelf Life of CDIL Products

The shelf life of products is the period from product manufacture to shipment to customers. The product can be unconditionally shipped within this period. The period is defined as 2 years.

If products are stored longer than the shelf life of 2 years the products shall be subjected to quality check as per CDIL quality procedure.

The products are further warranted for another one year after the date of shipment subject to the above conditions in CDIL original packing.

Floor Life of CDIL Products and MSL Level

When the products are opened from the original packing, the floor life will start. For this, the following JEDEC table may be referred:

JEDEC MSL Level			
Level	Time	Condition	
1	Unlimited	≤30 °C / 85% RH	
2	1 Year	≤30 °C / 60% RH	
2a	4 Weeks	≤30 °C / 60% RH	
3	168 Hours	≤30 °C / 60% RH	
4	72 Hours	≤30 °C / 60% RH	
5	48 Hours	≤30 °C / 60% RH	
5a	24 Hours	≤30 °C / 60% RH	
6	Time on Label(TOL)	≤30 °C / 60% RH	





Customer Notes

Component Disposal Instructions

- CDIL Semiconductor Devices are RoHS compliant, customers are requested to please dispose as per prevailing Environmental Legislation of their Country.
- 2. In Europe, please dispose as per EU Directive 2002/96/EC on Waste Electrical and Electronic Equipment (WEEE).

Disclaimer

The product information and the selection guides facilitate selection of the CDIL's Semiconductor Device(s) best suited for application in your product(s) as per your requirement. It is recommended that you completely review our Data Sheet(s) so as to confirm that the Device(s) meet functionality parameters for your application. The information furnished in the Data Sheet and on the CDIL Web Site/CD are believed to be accurate and reliable. CDIL however, does not assume responsibility for inaccuracies or incomplete information. Furthermore, CDIL does not assume liability whatsoever, arising out of the application or use of any CDIL product; neither does it convey any license under its patent rights nor rights of others. These products are not designed for use in life saving/support appliances or systems. CDIL customers selling these products (either as individual Semiconductor Devices or incorporated in their end products), in any life saving/support appliances or systems or applications do so at their own risk and CDIL will not be responsible for any damages resulting from such sale(s).

CDIL strives for continuous improvement and reserves the right to change the specifications of its products without prior notice.



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